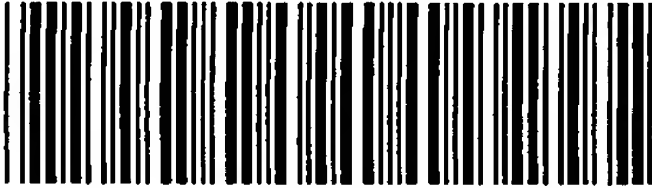
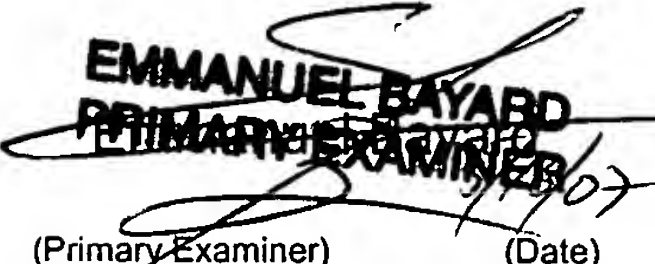
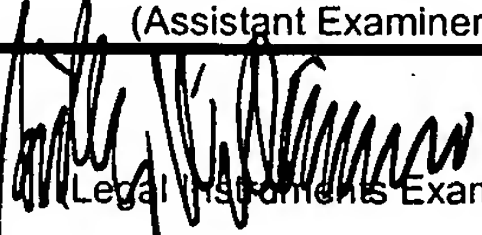
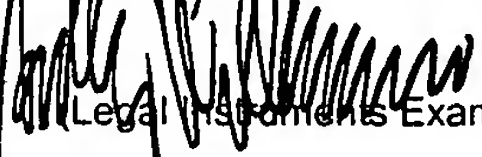


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/026,618	LEE ET AL.	
	Examiner	Art Unit	
	Emmanuel Bayard	2611	

ISSUE CLASSIFICATION													
ORIGINAL					CROSS REFERENCE(S)								
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							
375		354			375	316							
INTERNATIONAL CLASSIFICATION													
H	0	4	L	7/00									
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				/									
				/									
					 EMMANUEL BAYARD PRIMARY EXAMINER (Primary Examiner) (Date)					Total Claims Allowed: 8			
 (Assistant Examiner) (Date)  (Legal Instruments Examiner) (Date)										O.G. Print Claim(s) 1		O.G. Print Fig. 6	

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant												<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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